	Search Terms
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7	DISPLACEMENTS
m	
4	DISTRIBUTIONS
2	ELECTRIC
9	ELECTRICS
7	AGETIC
æ	MAGNETIC
٥	MAGNETICS
0	PROBE
11	PROBES
12	SAMPLED
13	SAMPLEDS
14	SAMPLER
15	SAMPLERS
16	SAMPLING
17	SAMPLINGS
18	HIHS
19	SHIFTING
20	SNILIINGS
21	SHIFTS
22	SPECTRUM
23	
24	SHIFTED
25	(((SPECTRUM SAME SHIFT) AND ((SAMPLER OR SAMPLED OR SAMPLING) SAME PROBE)) AND ((DISTRIBUTION SAME (SHIFTED OR SHIFTING OR DISPLACEMENT OR SHIFT)) SAME (ELECTROMAGETIC OR ELECTRIC OR MAGNETIC)))

	T tal	USPAT	US-PGPUB	EPO	Odc	Derwent	IBM TDB	USOCR
1	568959							
7	48219							
£	856177							
4	54979							
S	3181797							
9	3699							
7	170							
8	1152972							
6	10688							
10	255258							_
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22	310891							
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	ם	-	D cument ID	Issue Date	Pages	Тійе	Current OR
1			US 20030109997 A1	20030612	14	Field distribution measuring method and device	702/76
2	Ø		US 20030067312 A1	20030410		Voltage testing and measurement	324/753
3	Ø		US 20030057972 A1	20030327	09	Voltage testing and measurement	324/752
4	\boxtimes		□ US 20030012733 A9	20030116		Method of using reduced dimensionality nuclear magnetic resonance spectroscopy for rapid chemical shift assignment and secondary structure determination of proteins	424/9.3
2	☒			20020411		Method of using reduced dimensionality nuclear magnetic resonance spectroscopy for rapid chemical shift assignment and secondary structure determination of proteins	424/9.3
9	☒		□ US 6512385 B1	20030128		Method for testing a device under test including the interference of two beams	

Current XRef	Retrieval Classif	Inventor	S	U	۵	7	т	4	ις.	Image Doc. Displayed	<u>k</u>
	T		Ø							US 20030109997	
		Pfaff, Paul et al.									
		Pfaff, Paul et al.								US 20030057972	
		Szyperski, Thomas A.									
		Szyperski, Thomas A.									
324/752; 324/765		Pfaff, Paul et al.									

	Search Terms
-	KITAYOSHI-HITOSHI
2	PROBE
3	PROBES
4	SHIFT
2	SHIFTING
9	SHIFTINGS
7	SHIFTS
8	SHIFTED
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1 105		T tal	USPAT	US-PGPUB	EPO	JPO	Derwent	IBM TDB	USOCR
2	_	105							
2	7	255258							
2	3	108114							
2	4	569287							
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	כ	-	D cument ID	Issue Date	Pages	Title	Current OR
1	Ø		🛭 🖂 US 20030109997 A1	20030612	14	:0030612 14 Field distribution measuring method and device 702/76	702/76
2	\boxtimes		⊠ □ US 5974178 A	19991026	19	Wavesource image visualization method using a partial division fast fourier transform	382/210
ж	☒		US 5656932 A	-		.9970812 Non-contact type wave signal observation apparatus 324/615	324/615
4	⊠		□ EP 1191340 A1	20020327		FIELD DISTRIBUTION MEASURING METHOD AND DEVICE	

Current XRef	Retrieval Classif	Invent r	S	v	•	7	m	4	ις.	Image D c. Displayed	F
		Kitayoshi, Hitoshi								US 20030109997	
 342/362; 359/9; 382/280		Kitayoshi, Hitoshi								US 5974178	
324/630; 324/76.12		Kitayoshi, Hitoshi									
		КІТАYOSHI, НІТОSHI									